Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/815,665	LEE, CHANG-HYEON
Examiner	Art Unit

Natalia Figueroa

2651

SEARCHED				
Class	Subclass	Date	Examiner	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
-				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
D. Davidson	7/18/2005	NFM	
360/31,53,64 (text serach only-see search history printout)	7/18/2005	NFM	
EAST (USPAT, EPO, JPO, DERWENT, USPGPUB, IBMTDB-see search history printout)	7/18/2005	NFM	